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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/800,777	FUKUZAWA ET AL.	
Examiner	Art Unit	
Christopher W. Fulton	2859	

	SEAR	CHED	
Class	Subclass	Date	Examiner
399	328 329	6/21/2005	CWF
219	216 388	1	J

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	OTES I STRATEGY)
	DATE	EXMR
Ex. Sophia Chen in class 399	6/21/2005	CWF